Searcn	notes
	MORE ENTER COMPLETE

Application/Control No.	Applicant(s)/Patent un Reexamination	der
10/652,074	FUKUSHIMA ET AL.	
Examiner	Art Unit	
Mark Konec	1751	

	SEAR	CHED	
Class	Subclass	Date	Examiner
252	512	4/20/2005	M.K.
252	514	3	7
ABOVE	TO DATE	7/5/05	· 11
	·		
:			
	_		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
VS16-1	B	2/5/05	w

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
Inv. Name Search		4/20/2005	M.K.
		- 	
WEST			
	٠		
	_		
·			
-			_
			·
- · · · - · · · - · · · · - · · · · · ·			